Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/648,969	TRIPLETT ET AL.	
Examiner	Art Unit	
Mark K. Han	3767	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE EXMR		
EAST text search	4/17/2006 mil		
Inventor name search	4/17/2006 mill		

Search Notes (continued)

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/648,969	TRIPLETT ET A	L.
Examiner	Art Unit	
Mark K. Han	3767	

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